

# OptiMOS™-5 Power-Transistor





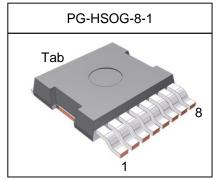
## **Features**

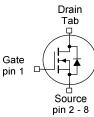
- N-channel Enhancement mode
- AEC qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- Ultra low Rds(on)
- 100% Avalanche tested

Туре	Package	Marking
IAUS200N08S5N023	PG-HSOG-8-1	5N08023

# **Product Summary**

V <sub>DS</sub>	80	V
R <sub>DS(on)</sub>	2.3	mΩ
I <sub>D</sub>	200	Α





# **Maximum ratings,** at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	$T_{\rm C}$ =25°C, $V_{\rm GS}$ =10V <sup>1)</sup>	200	Α
		T <sub>C</sub> =100 °C, V <sub>GS</sub> =10 V <sup>2)</sup>	148	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	800	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	/ <sub>D</sub> =100 A	330	mJ
Avalanche current, single pulse	IAS	-	200	А
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	200	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	-	0.7	K/W

# **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

# Static characteristics

Drain-source breakdown voltage <sup>2)</sup>	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	80	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 130  \mu {\rm A}$	2.2	3	3.8	
Zero gate voltage drain current <sup>2)</sup>	I <sub>DSS</sub>	V <sub>DS</sub> =80 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =25 °C	-	0.1	1	μA
		$V_{DS}$ =40 V, $V_{GS}$ =0 V, $T_j$ =85 °C <sup>2)</sup>	-	1	20	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =6 V, I <sub>D</sub> =50 A	-	2.7	3.7	mΩ
		V <sub>GS</sub> =10 V, I <sub>D</sub> =100 A		1.8	2.3	



Parameter	Symbol Condit	Conditions	ions		Values	
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	Ciss		-	5900	7670	pF
Output capacitance	Coss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =40 V, f=1 MHz	-	980	1274	
Reverse transfer capacitance	C <sub>rss</sub>		-	45	68	
Turn-on delay time	$t_{d(on)}$		-	16	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =40 V, V <sub>GS</sub> =10 V,	-	11	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =100 A, $R_{\rm G}$ =3.5 Ω	-	30	-	
Fall time	$t_{f}$		-	32	-	
Gate Charge Characteristics <sup>2)</sup>				,		1
Gate to source charge	Q <sub>gs</sub>		-	28	36	nC
Gate to drain charge	$Q_{gd}$	$V_{\rm DD}$ =40 V, $I_{\rm D}$ =100 A, $V_{\rm GS}$ =0 to 10 V	-	18	28	
Gate charge total	$Q_g$		-	85	110	
Gate plateau voltage	V <sub>plateau</sub>		-	4.8	ı	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	Is	T _25 °C	-	-	200	Α
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	- T <sub>C</sub> =25 °C	-	-	800	
Diode forward voltage	$V_{SD}$	V <sub>GS</sub> =0 V, I <sub>F</sub> =100 A, T <sub>j</sub> =25 °C	-	0.9	1.2	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	V <sub>R</sub> =40 V, I <sub>F</sub> =50A, di <sub>F</sub> /dt=100 A/μs	-	65	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>		-	110	-	nC

 $<sup>^{1)}</sup>$  Current is limited by bondwire; with an  $R_{\rm thJC}$  = 0.7 K/W the chip is able to carry 216A at 25°C.

<sup>&</sup>lt;sup>2)</sup> Defined by design. Not subject to production test.

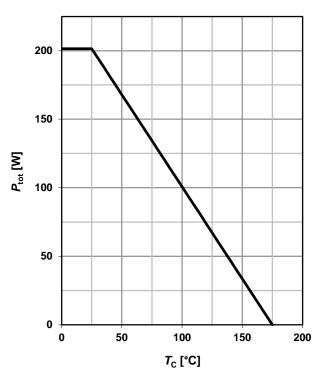


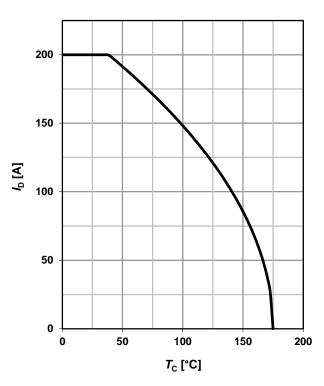
# 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

# 2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}$$





# 3 Safe operating area

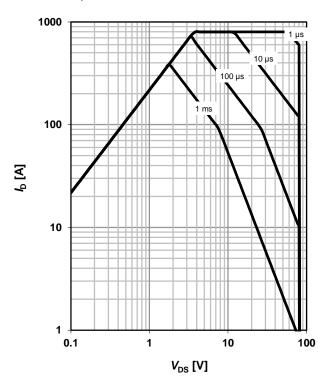
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

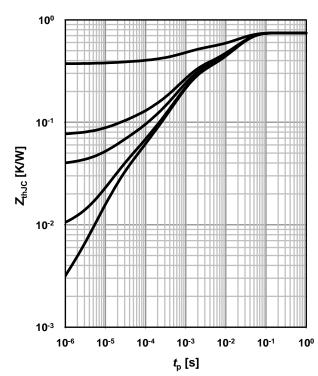
parameter:  $t_p$ 

# 4 Max. transient thermal impedance

$$Z_{thJC} = f(t_p)$$

parameter:  $D=t_p/T$ 







# 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$ 

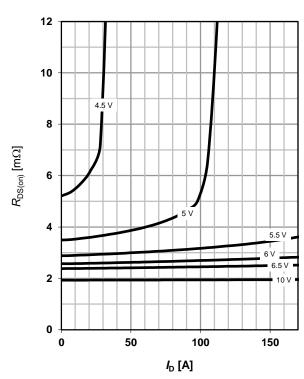
parameter:  $V_{\rm GS}$ 

# 700 6.5 V 6.

# 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}$ 

parameter: V<sub>GS</sub>



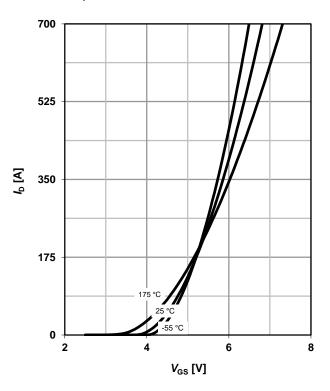
# 7 Typ. transfer characteristics

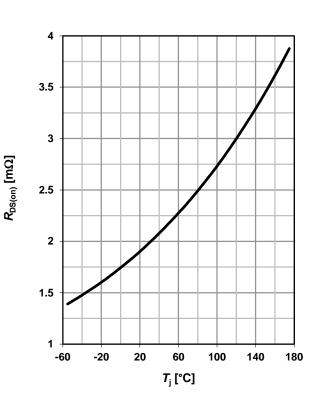
 $I_D = f(V_{GS}); V_{DS} = 6V$ 

parameter:  $T_j$ 

# 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}$$







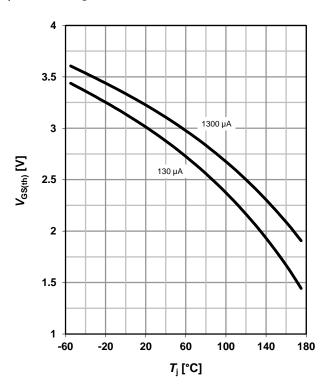
# 9 Typ. gate threshold voltage

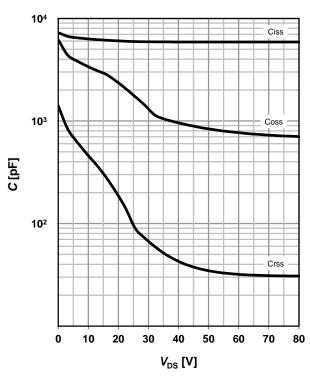
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_D$ 

# 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 





# 11 Typical forward diode characteristics

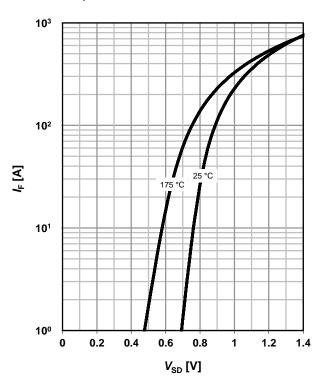
 $IF = f(V_{SD})$ 

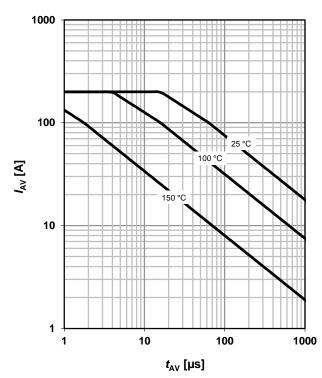
parameter: T<sub>i</sub>

# 12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>j(start)</sub>







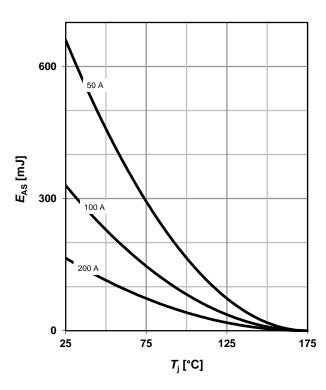
# 13 Typical avalanche energy

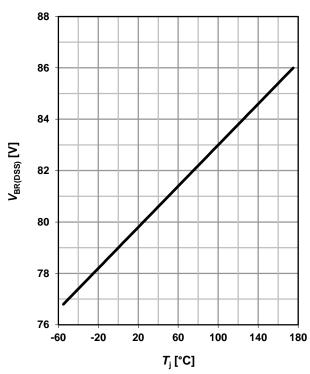
 $E_{AS} = f(T_i)$ 

parameter:  $I_D$ 

# 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_{D_{typ}} = 1 \text{ mA}$$



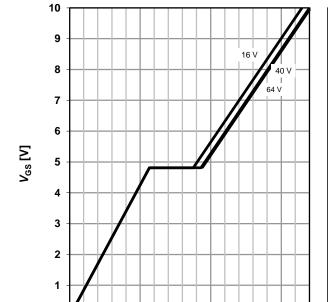


# 15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 100 A pulsed$ 

parameter: V<sub>DD</sub>

0

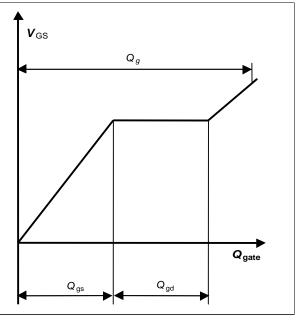


25

50

 $Q_{\mathrm{gate}}$  [nC]

# 16 Gate charge waveforms



75



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If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



# Revision History

Version	Date	Changes
Version 1.0	25.05.2018	Final Data Sheet
Version 1.1	09.05.2023	product marking updated